

Resource Summary Report

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Agilent: 5900 ICP-OES Instrument

RRID:SCR_019416

Type: Tool

Proper Citation

Agilent: 5900 ICP-OES Instrument (RRID:SCR_019416)

Resource Information

URL: <https://www.agilent.com/en/products/icp-oes/icp-oes-instruments/5900-icp-oes-instrument>

Proper Citation: Agilent: 5900 ICP-OES Instrument (RRID:SCR_019416)

Description: ICP-OES Instrument is used to run samples with Synchronous Vertical Dual View (SVDV) and captures both the axial and radial views of the plasma in one reading.

Resource Type: instrument resource

Keywords: Agilent, ICP-OES, Instrument Equipment, USEdit,

Availability: Commercially available

Specification URL: https://raw.githubusercontent.com/SciCrunch/RRID-Instruments/refs/heads/main/PDF/SCR_019416.pdf

Resource Name: Agilent: 5900 ICP-OES Instrument

Resource ID: SCR_019416

Alternate IDs: Model_Number_5900

Record Creation Time: 20220129T080345+0000

Record Last Update: 20260912T195914+0000

Ratings and Alerts

No rating or validation information has been found for Agilent: 5900 ICP-OES Instrument.

No alerts have been found for Agilent: 5900 ICP-OES Instrument.

Data and Source Information

Source: [SciCrunch Registry](#)

Usage and Citation Metrics

We have not found any literature mentions for this resource.